

Search Notes

Application/Control No.

10/509,563

Examiner

TUYEN T. NGUYEN

Applicant(s)/Patent under
Reexamination

KIM ET AL.

Art Unit

2832

SEARCHED

Class	Subclass	Date	Examiner
439	217-218, 222-223, 650, 653	1/23/2006	TTN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR